## Supplementary Information

### Metal Oxide Arrays from Block Copolymer Thin Film Templates

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## Methods for Sample Preparation

Description	Manuscript reference	Substrate	Annealing procedure	Metal precursor solution
PS-b-PEO	Figure 1a	Si	toluene vapor, 18 h	N/A
PS-b-PEO	Figure 1b	Si	toluene/water vapor (98 % RH), 18 h	N/A
EISA TiO <sub>2</sub>	Figure 1c	SiO <sub>2</sub>	toluene vapor, 2 h	0.7 g titanium tetraisopropoxide, 0.25 g HCl solution (37% in water), 0.5 mL 2-propanol stirred for 30 min
SPICE TiO <sub>2</sub>	Figure 1d	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	0.7 g titanium tetraisopropoxide, 0.25 g HCl solution (37% in water), 0.5 mL 2-propanol
SPICE Au/TiO <sub>2</sub>	Figure 1e	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	0.7 g titanium tetraisopropoxide, 0.25 g HCl solution (37% in water), 0.5 mL 2-propanol stirred for 30 min
PS- <i>b</i> -PEO -Ti	Figure 2a	Transfer from SiO <sub>2</sub> to Cu grid	toluene/water vapor (98 % RH), 2 h	0.7 g titanium tetraisopropoxide, 0.25 g HCl solution (37% in water), 0.5 mL 2-propanol stirred for 30 min
PS- <i>b</i> -PEO -Ti	Figure 2b	Transfer from SiO <sub>2</sub> to Cu grid	toluene vapor, 2 h	0.7 g titanium tetraisopropoxide, 0.25 g HCl solution (37% in water), 0.5 mL 2-propanol stirred for 30 min
SPICE TiO <sub>2</sub>	Figure 2c	Transfer from SiO <sub>2</sub> to SiN grid	toluene/water vapor (98 % RH), 18 h	0.7 g titanium tetraisopropoxide, 0.25 g HCl solution (37% in water), 0.5 mL 2-propanol stirred for 30 min
SPICE MgO	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	1 M in ethanol stirred for 30 min
SPICE $Al_2O_3$	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	1 M in ethanol stirred for 30 min
SPICE MnO <sub>2</sub>	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	1 M in ethanol stirred for 30 min

Table S1. Sample preparation methods prior to immersion and polymer removal.

SPICE Fe <sub>2</sub> O <sub>3</sub>	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	1 M in ethanol stirred for 30 min
SPICE Co <sub>3</sub> O <sub>4</sub>	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	1 M in ethanol stirred for 30 min
SPICE NiO	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	1 M in ethanol stirred for 30 min
SPICE CuO	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	1 M in ethanol stirred for 30 min
SPICE ZnO	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	1 M in ethanol stirred for 30 min
SPICE ZrO <sub>2</sub>	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	0.5 M in 50:50 vol ethanol:water solution stirred for 30 min
SPICE RuO <sub>2</sub>	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	1 M in ethanol stirred for 30 min
SPICE SnO <sub>2</sub>	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	1 M in ethanol stirred for 30 min
SPICE Ce <sub>2</sub> O <sub>3</sub>	Figure S1	SiO <sub>2</sub>	toluene/water vapor (98 % RH), 18 h	1 M in ethanol stirred for 30 min



# Atomic Force Microscopy (AFM) of Metal Oxides



**Figure S1**. AFM height images of metal oxides templated by the SPICE method: (a) MgO, (b)  $Al_2O_3$ , (c)  $MnO_2$ , (d)  $Fe_2O_3$ , (e)  $Co_3O_4$ , (f) NiO, (g) CuO, (h) ZnO, (i)  $ZrO_2$ , (j)  $SnO_2$ , (k)  $Ce_2O_3$ , and (l)  $RuO_2$ . Insets are FFTs of the entire image. Scale bars represent 200 nm.

The SPICE method was used to template MgO, Al<sub>2</sub>O<sub>3</sub>, MnO<sub>2</sub>, Fe<sub>2</sub>O<sub>3</sub>, Co<sub>3</sub>O<sub>4</sub>, NiO, CuO, ZnO, ZrO<sub>2</sub>, SnO<sub>2</sub>, Ce<sub>2</sub>O<sub>3</sub>, and RuO<sub>2</sub>. TiO<sub>2</sub> is shown in the main text of the manuscript. Representative AFM height images are shown in Figure S1. FFTs of the image are shown in the insets. The 6-spot pattern is characteristic of hexagonal packing.

## **XPS of Metal Oxides**

Table S1. XPS peak positions and associated full width half maxima (F	WHM).
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Metal oxide	Position (eV)	FWHM (eV)	Metal oxide	Position (eV)	FWHM (eV)
MgO			ZnO		
2p	50.8	1.7	2p <sub>3/2</sub>	1022.7	1.8
RuO <sub>2</sub>			TiO <sub>2</sub>		
3d <sub>5/2</sub>	280.7	1.8	2p <sub>3/2</sub>	458.9	1.3
			2p <sub>1/2</sub>	464.6	2.3
$Al_2O_3$			$Fe_2O_3$		
2p	74.6	1.8	2p <sub>3/2</sub>	711.2	2.8
			shake-up	718.6	5.1
$CeO_2$			2p <sub>1/2</sub>	724.9	4.0
3d <sub>3/2</sub>	916.5	4.4	shake-up	728.2	13.3
MnO <sub>2</sub>			NiO		
$2p_{3/2}$	642.2	2.7	2p <sub>3/2</sub>	856.7	2.0
shake-up	645.6	5.5	shake-up	861.6	7.8
$2p_{1/2}$	654.0	2.5	2p <sub>1/2</sub>	874.3	2.6
shake-up	655.3	9.1	shake-up	880.0	6.9
Co <sub>3</sub> O <sub>4</sub>			Ce <sub>2</sub> O <sub>3</sub>		
2p <sub>3/2</sub>	781.7	2.7	3d <sub>5/2</sub>	882.0	3.0
shake-up	786.2	8.1	3d <sub>5/2</sub>	885.8	3.9
2p <sub>1/2</sub>	797.2	3.5	3d <sub>3/2</sub>	900.0	3.5
shake-up	802.9	7.2	3d <sub>3/2</sub>	904.2	5.2
CuO			ZrO <sub>2</sub>		
2p <sub>3/2</sub>	932.9	1.3	3d <sub>5/2</sub>	182.7	1.4
shake-up	942.4	5.9	3d <sub>3/2</sub>	185	1.5
2p <sub>1/2</sub>	952.6	1.8			
shake-up	962.4	3.7			
Cu(OH) <sub>2</sub>			SnO <sub>2</sub>		
2p <sub>3/2</sub>	934.7	3.7	3d <sub>5/2</sub>	487.3	1.4
2p <sub>1/2</sub>	954.6	3.1	3d <sub>3/2</sub>	495.7	1.4

XPS data were fit using CasaXPS to determine peak positions and FHWM. Metal oxide signatures were evident in all spectra. No evidence of precursor salts or metals was noted.

#### **Titania Loading**

By comparing the PEO cylinder volume ( $V_{PEO}$ ) to the TiO<sub>2</sub> volume ( $V_{TiO_2}$ ), a loading ratio can be calculated. The measured height of titania dots, which has a density ( $P_{TiO_2}$ ) and formula weight ( $FW_{TiO_2}$ ), was 5.4 ± 1.4 nm when using PS-*b*-PEO films, which had a PEO density ( $P_{PEO}$ ) and monomer formula weight ( $FW_{PEO unit}$ ), that were 30 nm thick. PEO cylinders and TiO<sub>2</sub> radii were 8.7 ± 0.8 nm and 8.5 ± 1.9 nm, respectively.

$$\left(\frac{\text{mol}_{Ti}}{\text{mol}_{PEO\ unit}}\right) = \left(\frac{V_{TiO_2} \cdot \rho_{TiO_2}}{FW_{TiO_2}}\right) \left(\frac{FW_{PEO\ unit}}{V_{PEO} \cdot \rho_{PEO}}\right)$$
(S1)

$$\begin{pmatrix}
\frac{\text{mol}_{Ti}}{\text{mol}_{PEO\ unit}} \\
= \left( \frac{1.3 \times 10^{-24} \text{m}^3 \cdot 4230 \text{ kg} \cdot \text{m}^{-3}}{0.079 \text{ kg} \cdot \text{mol}^{-1}} \right) \cdot \left( \frac{0.044 \text{ kg} \cdot \text{mol}^{-1}}{7.1 \times 10^{-24} \text{m}^3 \cdot 1130 \text{ kg} \cdot \text{m}^{-3}} \right)$$

$$\begin{pmatrix}
\frac{\text{mol}_{Ti}}{\text{mol}_{PEO\ unit}} \\
= 0.38
\end{cases}$$
(S2)

The loading ratio ( $mol_{Ti}:mol_{PEO} unit = 0.38$ ) is less than traditional EISA methods, which can reach up to 2 by employing micelles. However, loading ratios by the SPICE method should be compared to work by Shan *et al.*; they achieved well-ordered arrays by complexing precursors with homopolymers prior to blending with a BCP solution.<sup>1</sup> The reported loading ratios were 0.18-0.30; however, the ratios were calculated based on the homopolymer solution and not the final precursor/homopolymer/BCP solution. In the case of the latter, the loading ratios would have been closer to 0.12-0.20. Therefore, the SPICE method uses relatively large precursor loading ratios and thus minimizes consumed polymer material.

### **Methylene Blue Catalysis**



**Figure S2.** Representative time-lapse UV-vis spectra of MB photocatalytically degraded by SPICE TiO<sub>2</sub>. MB solutions were exposed to catalyst and UV irradiation in UV-transparent cuvettes. Inset contains the entire UV-vis spectra of a MB aqueous solution. The peaks between 550-740 nm (solid) were used to evaluate the photocatalytic activity of SPICE TiO<sub>2</sub>, EISA TiO<sub>2</sub>, and Au/SPICE-TiO<sub>2</sub> Au/EISA-TiO<sub>2</sub> surfaces.

MB was used to demonstrate the improved photocatalytic activity of SPICE  $TiO_2$  over traditional EISA  $TiO_2$ . The peaks between 550-750 nm were used to monitor the photocatalytic degradation of MB. Instrument drift was monitored by analyzing a stock MB solution that was not exposed to UV irradiation (Figure S2 inset) prior to each measurement. Time-lapse data clearly exhibit decreases in peak intensity. MB solution concentrations, which were based on integrated peak areas, were fit to first-order kinetics to determine rate constants (Figure 3). By monitoring the UV-vis spectra, it was shown that SPICE  $TiO_2$  was 13% more effective than EISA  $TiO_2$ .

### **TiO<sub>2</sub> Dispersion**



**Figure S3.** Size distributions of EISA and SPICE  $\text{TiO}_2$  were measured according to the AFM images in Figure 1c and Figure 1d, respectively. Radii were calculated using ImageJ and binned in 0.5 nm increments. Counts (y-axis) were normalized for the purposes of comparison. Radii ( $r_x$ ) represent the average and standard deviation of each data set. The data represent over 2700 measurements for each AFM image.

The SPICE method produced a narrower distribution of TiO<sub>2</sub> than the EISA method. The narrower distribution was qualitatively evident by the line scan in Figure 1f, but it is quantified here. The variance ( $\sigma$ ) within the distribution of radii were  $\sigma_{SPICE} = 3.5$  nm and  $\sigma_{EISA} = 19.6$  nm. The index of dispersion (*D*) was calculated by the following expression:

$$D = \frac{\sigma^2}{\mu},$$
 (S4)

for which  $\mu$  is the number average of the distribution. The indices of dispersion were  $D_{SPICE}$  = 1.5 nm and  $D_{EISA}$  = 39.2 nm. This narrower size distribution is one of the key benefits of the

SPICE method over the traditional EISA method.

1. Shan, L.; Punniyakoti, S.; Van Bael, M. J.; Temst, K.; Van Bael, M. K.; Ke, X.; Bals, S.; Van Tendeloo, G.; D'Olieslaeger, M.; Wagner, P.; Haenen, K.; Boyen, H.-G.; *J. Mater. Chem. C* 2014, *2*, 701-707.